Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10783170	GAI ET AL.
Examiner	**Art Unit**
Tu, Julia P	2611

ORIGINAL		INTERNATIONAL CLASSIFICATION									
CLASS	SUBCLASS	CLAIMED					NON-CLAIMED				
375	232	H	0	3	K	5 / 159 (2006.01.01)					

CROSS REFERENCE(S)					
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
375	229	231			

Tu, Julia P (Assistant Examiner)	06/13/2007 (Date)	Chieh M. Fan	**Total Claims Allowed:** 22
(Legal Instruments Examiner) (Date)	CHIEH M. FAN SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) 6/19/07	O.G. Print Claim(s) 1	O.G. Print Figure 1